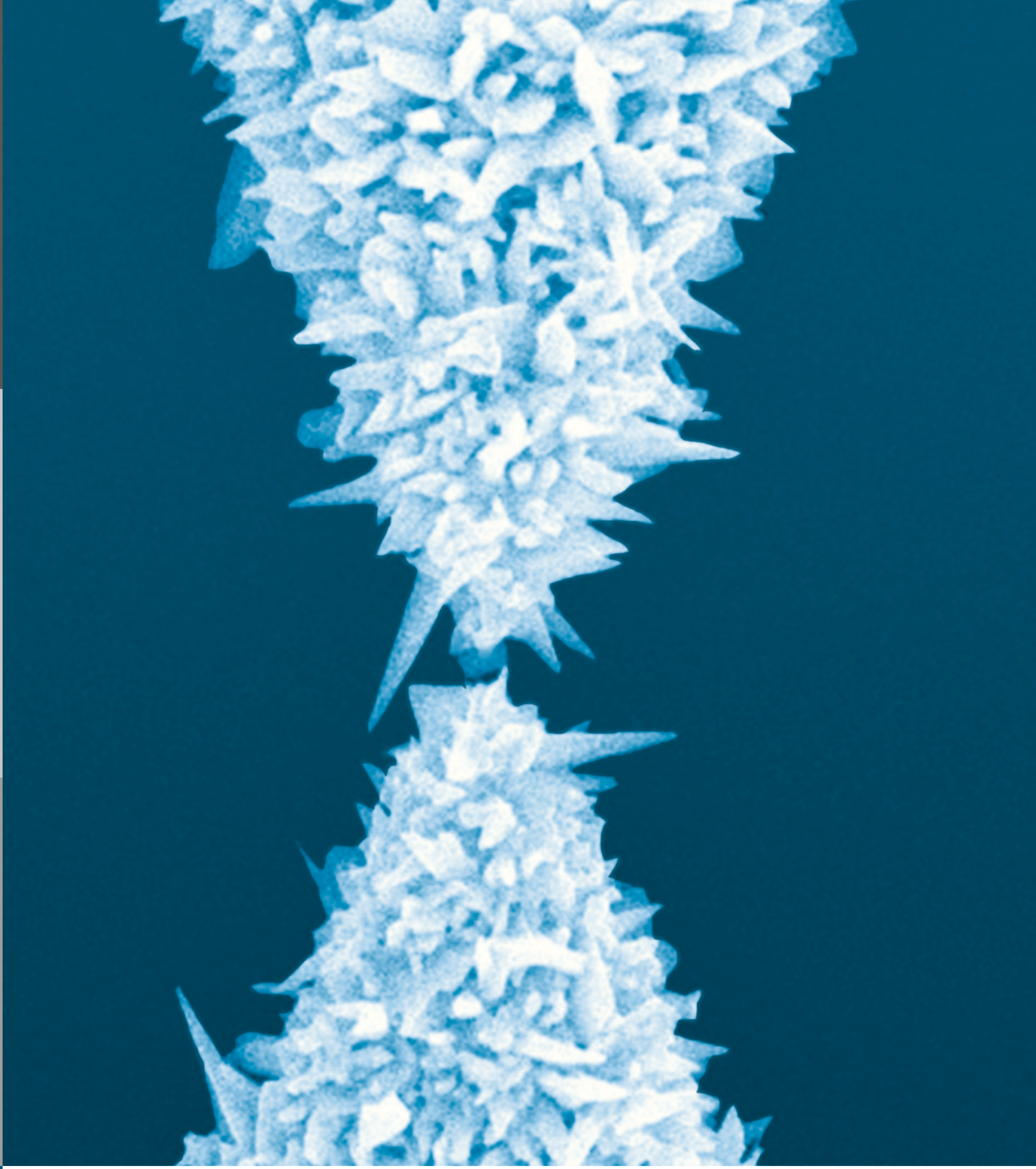

Fabrication of Nanogaps and Investigation of Molecular Junctions by Electrochemical Methods

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Contents

1. Introduction **5**

2. Fundamentals **9**
- 2.1. Electron transport in nanometer scale 9
  - 2.1.1. Atomic scale junctions and conductance quantization 10
  - 2.1.2. Electron tunneling through nanogaps 16
  - 2.1.3. Electron transport through molecules 20
- 2.2. Electrochemistry 24
  - 2.2.1. Electrochemical interface 25
  - 2.2.2. Standard electrode potential and Nernst equation 26
  - 2.2.3. Faradaic current and nonfaradaic current 28
  - 2.2.4. Diffusion in nanoscale 32
  - 2.2.5. Electrochemical deposition 33

3. Experimental Methods **37**
- 3.1. Nanogap fabrication 37
  - 3.1.1. Layout design 37
  - 3.1.2. Optical lithography 38
  - 3.1.3. Electron beam lithography 41
  - 3.1.4. Insulation and connection of nanoelectrodes 42
- 3.2. Electrochemical experiments 44
  - 3.2.1. Electrochemical investigation of macroelectrodes 45
  - 3.2.2. Electrochemical investigation of nanoelectrodes 46
  - 3.2.3. Electrochemical break junction setup 46
- 3.3. Molecular junction assembly and measuring 47
  - 3.3.1. Au/Benzenedithiol/Au junctions 48
  - 3.3.2. Au/cysteamine/ferrocene/cysteamine/Au junctions 48

4. Results and Discussions **51**
- 4.1. Nanogap chip fabrication 52
  - 4.1.1. Micro-scale structures fabricated by optical lithography 52

4.1.2. Nanogap fabricated by electron beam lithography 55
4.1.3. Fabricating nanogaps by focused beam etching 63
4.1.4. Insulation of the electrodes 64
4.2. Electrochemical modification of nanogap electrodes 71
4.2.1. Cyclic voltammetry 72
4.2.2. Potentiostatic deposition and morphology modification 75
4.2.3. Potentiodynamic deposition 81
4.2.4. Fine tuned nanoscale gaps and atomic scale junctions 82
4.3. Benzenedithiol junction assembled on fixed nanogaps 87
4.4. Electrochemical mechanical controlled break junction (MCBJ) 90
4.4.1. Electrochemical mechanical break junction setups 90
4.4.2. In-situ deposition and breaking 91
4.4.3. Characterization of the electrochemical break junction setup 94
4.5. Electrostatically linked Ferrocene junctions assembled on MCBJ 98

5. Conclusions and Outlook 107

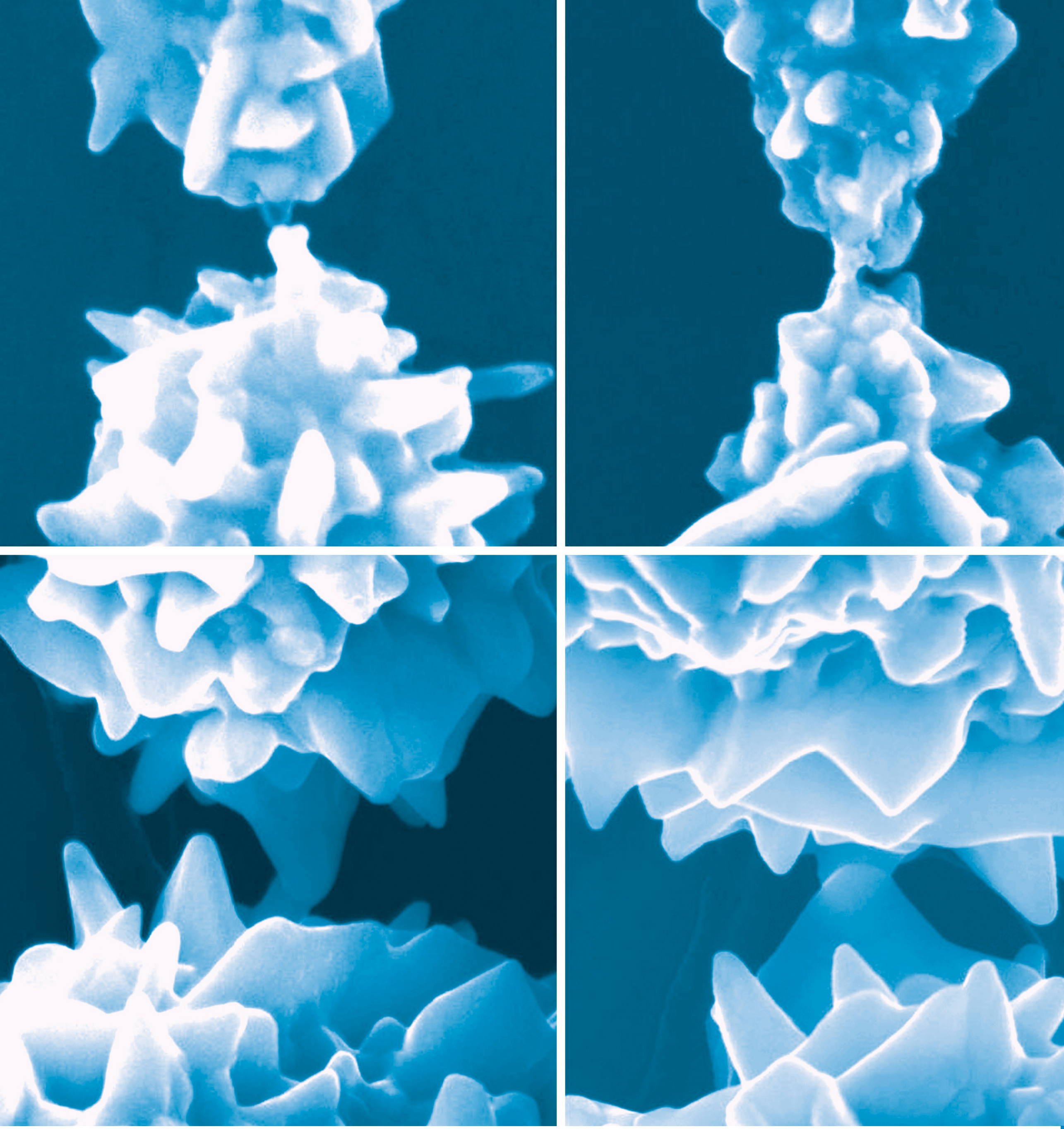
Appendices 109

A. Materials and Devices 111
A.1. Optical lithography 111
A.2. Electron beam lithography 112
A.3. Focused Ion Beam (FIB) 112
A.4. Electrode Insulation 112
A.5. Chip encapsulation 112
A.6. Electrochemical experiments 112

B. Publication lists 115

Bibliography 115

Acknowledgement / Danksagung 133



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